Signals

•Signal

generalised name for input into instrument system

•Might seem logical to consider signals before sensors but can now see

wide range of signal types are possible depend on sensor depend on any further transformation - eg light to electrical

•Most common types of signal

short, random pulses, usually current, amplitude carries information
 typical of radiation sensors
 trains of pulses, often current, usually binary
 typical of communication systems
 continuous, usually slowly varying, quantity - eg. current or voltage
 slow - typical of monitoring instruments
 fast - eg cable TV, radio
•terms like "slow", "fast" are very relative!

Typical signals

•Some examples

Signal source	Duration
Inorganic scintillator	e ^{-t/} ~ few μs
Organic scintillator	$e^{-t/}$ ~ few ns
Cerenkov	~ns
Gaseous	few ns - µs
Semiconductor	~10ns
Thermistors	continuous
Thermocouple	continuous
Laser	pulse train ~ps rise time
	or short pulses ~fs

•However, we will find later that speed of signal is not always sufficient to build fast responding systems

Signal formation

•Issues in practical applications

duration

radiation: depends on transit time through sensor and details of charge induction process in external circuit

linearity

most radiation sensors characterised, or chosen for linearity for commercial components can expect non-linearity, offset and possible saturation

reproducibility

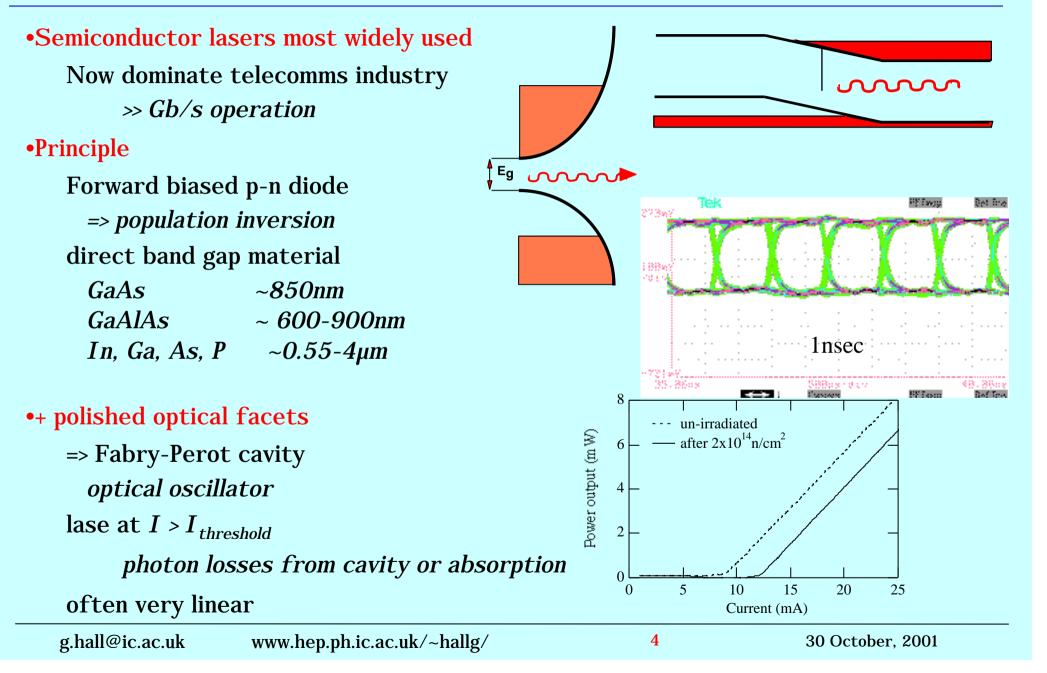
eg. many signals are temperature dependent in magnitude - mobility of charges other effects easily possible

ageing

sensor signals can change with time for many reasons natural degradation of sensor, variation in operating conditions, radiation damage,...

•all these effects mean one should always be checking or calibrating measurements intended for accuracy as best one can

Optical transmitters



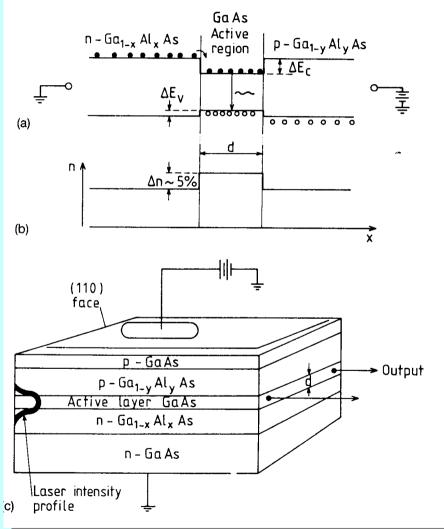
Modern semiconductor lasers

•Quantum well structures

confine charge carriers to active layer
 refractive index difference
 => waveguide confines light
minimise lateral dimensions for efficiency
& low I
threshold
 =>low power (~mW), miniature devices
 well matched for optical fibre transmission

•VCSELs Vertical Cavity Surface Emitting Laser emit orthogonal to surface ultra-low power cheap to make (test on wafer) can be made in arrays non-linear L-I characteristic

but very suitable for digital applications



Passage of radiation through matter

•Need to know a few elementary aspects of signal formation whether interested in light or other radiation

How far does radiation penetrate?

How much of incident energy is absorbed?

•Signal current - duration and magnitude

consequence of charge carriers generated electrons + holes (semiconductor) or ions (gases, liquids) current duration depends on

distance over which charge deposited

rapid absorption or thin sensor give fast signals electric field

only charges in motion generate currents current in external circuit is **induced**

Light

•I ~ $I_0 \exp(-L/L_{abs})$ $1/L_{abs} = N_{atom}$ $N_{atom} = N_{Avogadro}/A = no. atoms per unit volume$ Photoabsorption $E \sim eV - 100 keV$ atom ionised in single process, all photon energy transferred at low energies depends on atomic properties of material $_{pa} \sim Z^{4-5}/E^{-3}$ above K-shell edge at higher energies •Compton scattering quantum collision of photon with charged particle, usually e-~MeV transfer of part of photon energy, often small •Pair production > MeVall energy transferred to e+e- pair to conserve momentum and energy, needs recoil must take place in field of nucleus or electron

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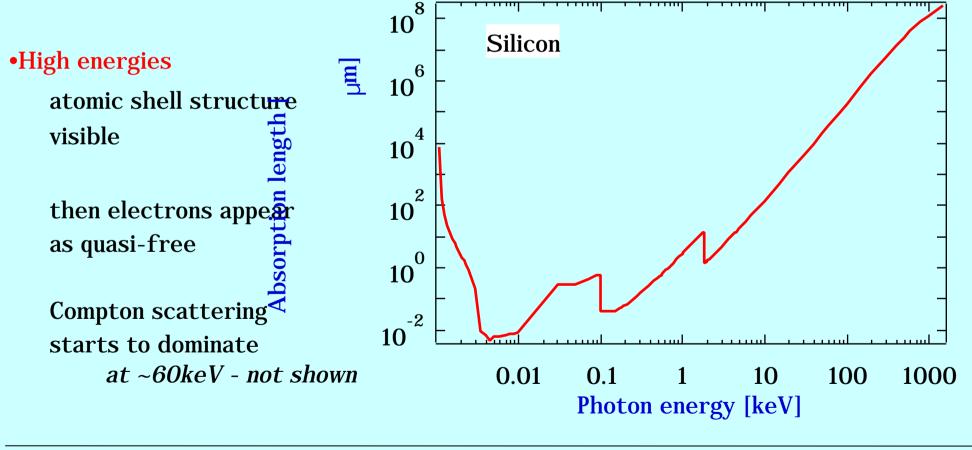
Light absorption-

•Low energies

see consequence of atomic behaviour

eg silicon bandgap

NB strong dependence on wavelength in near-visible regions



Light absorption

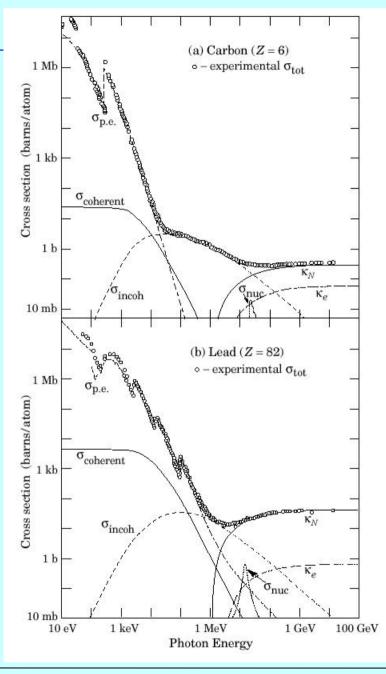
•Far UV to x-ray energies atomic shell structure *photo-absorption*

coherent = Rayleigh scattering
 atom neither ionised nor nor excited

incoherent = Compton $\sigma = Zf(E_{\gamma})$

pair production $E > 2m_e$ contributions from nucleus (~Z²) and atomic electrons (~Z)

small contribution from nuclear interactions



Charged particles

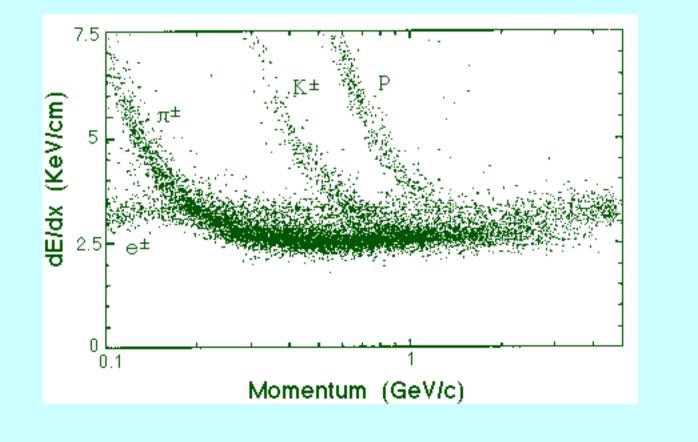
•Ionisation dominates Units: $x = density x thickness = [g.cm^{-2}]$

Stopping power = dE/dx scales in similar way for all particles with p/m =

dominated by interactions with atomic electrons μ^+ on Cu Stopping power [MeV cm²/g] •low energies 100 slow particles lose energy rapidly Bethe-Bloch Anderson dE/dx increases with β Ziegler ndharc charff to maximum Bragg peak 10 Radiative Minimum effects •relativistic energies ionization reach 1% Nuclear decline ~ $1/^{2}$ losses to minimum value 0.0010.01 0.1 10100 1000 further slow rise $\sim \log(p/m)$ 1 βγ 10 100 10 100 0.1 1 most cosmic rays and high energy [MeV/c] [GeV/c] particles approximately MIPs Muon momentum 10 g.hall@ic.ac.uk www.hep.ph.ic.ac.uk/~hallg/ 30 October, 2001

dE/dx

•Measured energy loss can provide another way of identifying particles gas detectors with multiple samples of E from same particle momentum measurement is needed - from bending in B field accompanied by good calibration of p and dE/dx



Electrons

•are special because of their low mass classically accelerated charge radiates
•brehmstrahlung radiation in matter acceleration in nuclear field
•synchrotron radiation in accelerators generates beams of low energy x-rays *typical E ~ 1-10keV* widely used for studying atomic properties, eg protein crystallography

•neutrons

do not generate ionisation directly so hard to measure

•at low energies

mostly elastic collisions with atoms in material simple kinematics determines energy transfer

 $T_{\text{max}} = 4AT_{\text{inc}}/(1+A)^2$

low Z materials favoured to absorb neutron energy

C, D_2O moderators in nuclear reactors hydrogenous or boron compounds used as detectors

Sensor equivalent circuits

•Many of the sensors considered so far can be modelled as

current source + associated capacitance

typical values ~ few pF

but can range from

~100fF semiconductor pixel

 ${\sim}10{\text{-}}20\text{pF}\,$ gas or Si microstrip, PM anode

~100pF large area diode

~µF wire chamber

usually there is some resistance associated with the sensor, eg leads or metallisation but this has little effect on signal formation or amplification

•Notable exception: microstrips - gas or silicon

the capacitance is distributed, along with the strip resistance

forms a dissipative transmission line

$\frac{1}{2} \quad \frac{1}{2} \quad \frac{1}$

